## Notice of References Cited Application/Control No. 10/802,320 Examiner Chau N. Nguyen Applicant(s)/Patent Under Reexamination FUNG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,297,455	10-2001	Wijnberg et al.	174/113R
	В	US-6,142,824	11-2000	Savoca et al.	439/531
	С	US-5,993,256	11-1999	Shimojyo, Yasuhiro	439/604
	D	US-5,674,095	10-1997	Tanhehco et al.	439/731
	Ε	US-4,834,677	05-1989	Archang, Homayoun	439/660
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			_
	к	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z	JP 2002-245860	08-2002	Japan	Ishii	
	0					
	Р					
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	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	V				
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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